

# Search Notes



Application/Control No.

10/501,073

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under  
Reexamination

TAKENAKA ET AL.

Art Unit

2834

## SEARCHED

Class	Subclass	Date	Examiner
310	52	5/10/2005	HN
310	54	5/10/2005	HN
310	58	5/10/2005	HN
310	64	5/10/2005	HN
update search	ALL	9/9/05	HN

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Consult Burton Mullins, primary Examiner for allowance	9/9/05	HN
PG PUB-Text search see interference search print out	9/9/05	HN